



STEREO DIGITAL AUDIO LIP-SYNC DELAY

FEATURES

- Digital Audio Format: 16-24-bit I²S
- Single Serial Input Port
- Delay Time: 170 ms/ch at fs = 48 kHz
- Delay Resolution: 256 samples
- Delay Memory Cleared on Power-Up or After Delay Changes
 - Eliminates Erroneous Data From Being Output
- 3.3 V Operation With 5 V Tolerant I/O
- Supports Audio Bit Clock Rates of 32 to 64 fs with fs = 32 kHz-192 kHz
- No External Crystal or Oscillator Required
 - All Internal Clocks Generated From the Audio Clock
- Surface Mount 4mm × 4mm, 16-pin QFN Package

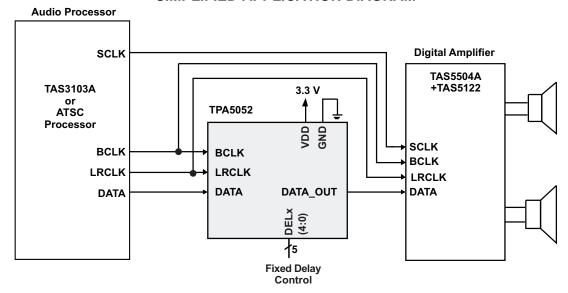
APPLICATIONS

- High Definition TV Lip-Sync Delay
- Flat Panel TV Lip-Sync Delay
- Home Theater Rear-Channel Effects
- Wireless Speaker Front-Channel Synchronization
- Camcorders

DESCRIPTION

The TPA5052 accepts a single serial audio input, buffers the data for a selectable period of time, and outputs the delayed audio data on a single serial output. In systems with complex video processing algorithms, one device allows delay of up to 170 ms/ch (fs = 48 kHz) to synchronize the audio stream to the video stream. If more delay is needed, the devices can be connected in series.

SIMPLIFIED APPLICATION DIAGRAM





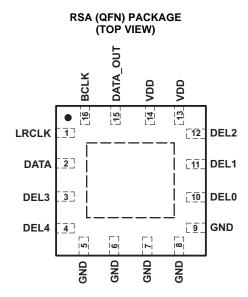
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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

PIN DESCRIPTIONS

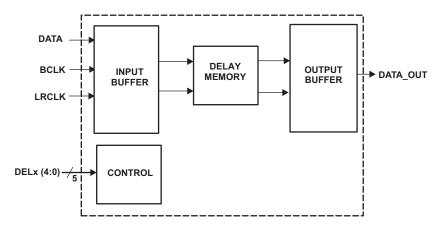


TERMINAL FUNCTIONS

TERMINAL		1/0	DESCRIPTION	
NAME	NO.	1/0	DESCRIPTION	
DEL0	10	I	Delay select pin – LSB. 5V tolerant input.	
DEL1	11	I	Delay select pin. 5V tolerant input.	
DEL2	12	1	Delay select pin. 5V tolerant input.	
DEL3	3	1	Delay select pin. 5V tolerant input.	
DEL4	4	1	Delay select pin - MSB. 5V tolerant input.	
BCLK	16	I	Audio data bit clock input for serial input. 5V tolerant input.	
DATA	2	1	Audio serial data input for serial input. 5V tolerant input.	
DATA_OUT	15	0	Delayed audio serial data output.	
GND	5–9	Р	Ground – All ground terminals must be tied to GND for proper operation	
LRCLK	1	1	Left and Right serial audio sampling rate clock (fs). 5V tolerant input.	
VDD	13, 14	Р	Power supply interface. Both pins must be tied to power supply.	
Thermal Pad		-	Connect to ground. Must be soldered down in all applications to properly secure device on the PCB.	



FUNCTIONAL BLOCK DIAGRAM



ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature (unless otherwise noted) (1)

			VALUE	UNIT
V_{DD}	Supply voltage		-0.3 to 3.6	V
VI	Input voltage	DATA, LRCLK, BCLK, DEL[4:0]	-0.3 to 5.5	V
	Continuous total	power dissipation	See Dissipation Rating Table	
T _A	Operating free-ai	r temperature range	-40 to 85	°C
T_{J}	Operating junctio	n temperature range	-40 to 125	°C
T _{stg}	Storage tempera	ture range	-65 to 125	°C
	Lead temperature	e 1,6 mm (1/16 inch) from case for 10 seconds	260	°C

⁽¹⁾ Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operations of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

DISSIPATION RATINGS(1)

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING
RSA	2.5 W	25 mW/°C	1.375 W	1 W

⁽¹⁾ This data was taken using 1 oz trace and copper pad that is soldered directly to a JEDEC standard high-k PCB. The thermal pad must be soldered to a thermal land on the printed-circuit board. See TI Technical Briefs SCBA017D and SLUA271 for more information about using the QFN thermal pad.

RECOMMENDED OPERATING CONDITIONS

			MIN	MAX	UNIT
V_{DD}	Supply voltage	VDD	3	3.6	V
V _{IH}	High-level input voltage	DATA, LRCLK, BCLK, DEL[4:0]	2		V
V _{IL}	Low-level input voltage	DATA, LRCLK, BCLK, DEL[4:0]		0.8	V
T_A	Operating free-air temperature				°C



DC CHARACTERISTICS

 $T_A = 25^{\circ}C$, $V_{DD} = 3 \text{ V}$ (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
I _{DD}	Supply current	V_{DD} = 3.3 V, fs = 48 kHz, BCLK = 32 × fs		1.8	3	mA
I _{OH}	High-level output current	DATA_OUT = 2.6 V	5		13	mA
I _{OL}	Low-level output current	DATA_OUT = 0.4 V	5		13	mA
	High lovel input ourrent	DATA, LRCLK, BCLK, V _I = 5.5V, VDD = 3V			20	^
'IH	High-level input current	DEL[4:0], V _I = 3.6V, VDD = 3.6V			5	μΑ
I _{IL}	Low-level input current	DATA, LRCLK, BCLK, DEL[4:0], V _I = 0V, VDD = 3.6V			1	μΑ

Serial Audio Input Ports

over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
f _{SCLKIN}	Frequency, BCLK $32 \times \text{fs}$, $48 \times \text{fs}$, $64 \times \text{fs}$		1.024		12.288	MHz
t _{su1}	Setup time, LRCLK to BCLK rising edge		10			ns
t _{h1}	Hold time, LRCLK from BCLK rising edge		10			ns
t _{su2}	Setup time, DATA to BCLK rising edge		10			ns
t _{h2}	Hold time, DATA from BCLK rising edge		10			ns
	LRCLK frequency		32	48	192	kHz
	BCLK duty cycle			50%		
	LRCLK duty cycle			50%		
	BCLK rising edges between LRCLK rising edges	LRCLK duty cycle = 50%	32		64	BCLK edges

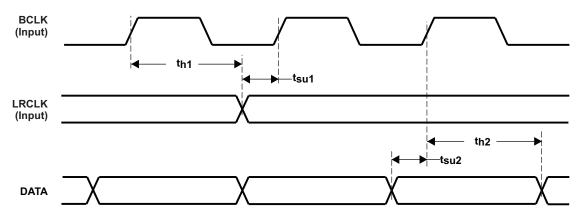


Figure 1. Serial Data Interface Timing



APPLICATION INFORMATION

AUDIO SERIAL INTERFACE

The audio serial interface for the TPA5052 consists of a 3-wire synchronous serial port. It includes LRCLK, BCLK, and DATA. BCLK is the serial audio bit clock, and it is used to clock the serial data present on DATA into the serial shift register of the audio interface. Serial data is clocked into the TPA5052 on the rising edge of BCLK. LRCLK is the serial audio left/right word clock. It is used to latch serial data into the internal registers of the serial audio interface. LRCLK is operated at the sampling frequency, fs. BCLK can be operated at 32 to 64 times the sampling frequency for I²S formats. A system clock is not necessary for the operation of the TPA5052.

I2S TIMING

The I²S data format diagram is shown in Figure 2.

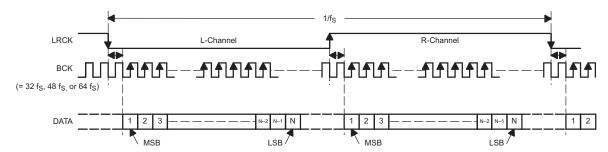


Figure 2. I²S Data Format; L-Channel = LOW, R-Channel = HIGH

GENERAL DELAY OPERATION

The delay of the TPA5052 is set using the 5 delay pins (DEL4, DEL3, DEL2, DEL1, DEL0). The minimum delay is 255 samples, and occurs when all five pins are at logic 0. The maximum delay is 8191 samples, and occurs when all five pins are at logic 1. The delay can be increased by changing the values on each pin from a 0 to a 1. See Table 1. Delay pin DEL4 is the MSB, and DEL0 is the LSB.

The delay is calculated with the following forumula:

Audio Delay (in samples) = $4096 \times (DEL4) + 2048 \times (DEL3) + 1024 \times (DEL2) + 512 \times (DEL1) + 256 \times (DEL0) + 255$

Audio Delay (ms) = Audio Delay (in samples) x (1/fs)

Both channels have the same amount of delay. They cannot be controlled individually.

DEL4	DEL3	DEL2	DEL1	DEL0	Delay in Samples
0	0	0	0	0	255
0	0	0	0	1	511
0	0	0	1	0	767
0	0	0	1	1	1023
\	\	\	\	\	\
1	1	1	1	1	8191

Table 1. Delay Settings



TPA5052 Operation

Only a single decoupling capacitor (0.1 μ F–1 μ F) is required across VDD and GND. The DELx terminals can be directly connected to VDD or GND. Table 1 describes the delay settings selectable via the DELx terminals. A schematic implementation of the TPA5052 is shown in Figure 3.

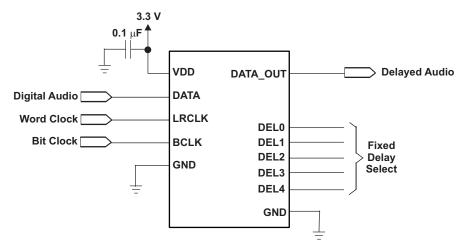


Figure 3. TPA5052 Schematic

COMPLETE UPDATE

To avoid pops and clicks in the audio stream when the delay is changed, the TPA5052 holds each channel in an internal mute mode until all the set number of samples have passed. For example, if the delay is set to 511 samples, the TPA5052 holds each channel in mute until all 511 samples of audio data have passed.



APPLICATION EXAMPLES

Connecting Two Devices in Series to Increase the Delay

It is sometimes desirable to increase the delay time beyond the limit which one device provides. In such cases, the TPA5052 device can be placed in a series to increase the delay. See Figure 4 for an example.

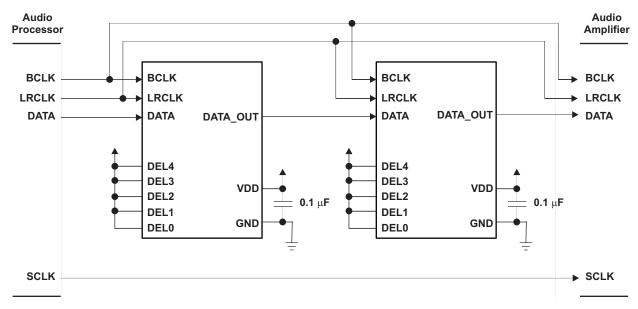
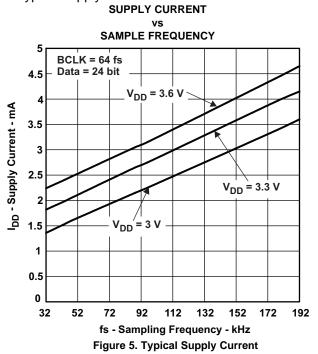


Figure 4. Two Devices in Series

DEVICE CURRENT CONSUMPTION

The TPA5052 draws different amounts of supply current depending upon the conditions under which it is operated. As V_{DD} increases, so too does I_{DD} . Likewise, as V_{DD} decreases, I_{DD} decreases. The same is true of the sampling frequency, fs. An increase in fs causes an increase in I_{DD} . Figure 5 illustrates the relationship between operating condition and typical supply current.







tom 12-Sep-2006

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
TPA5052RSAR	ACTIVE	QFN	RSA	16	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
TPA5052RSARG4	ACTIVE	QFN	RSA	16	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
TPA5052RSAT	ACTIVE	QFN	RSA	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
TPA5052RSATG4	ACTIVE	QFN	RSA	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

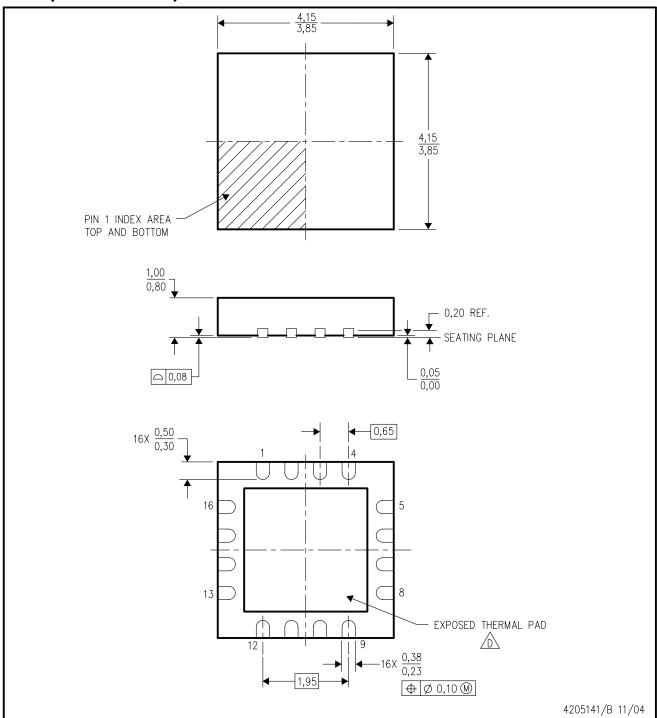
(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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RSA (S-PQFP-N16)

PLASTIC QUAD FLATPACK



- NOTES: All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 - This drawing is subject to change without notice.
 - Quad Flatpack, No-leads (QFN) package configuration.
 - The package thermal pad must be soldered to the board for thermal and mechanical performance. See the Product Data Sheet for details regarding the exposed thermal pad dimensions.
 - E. Falls within JEDEC MO-220.



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